## Lu Liu

## List of Publications by Citations

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28 916 48 17 h-index g-index papers citations 2.6 1,056 3.76 49 L-index avg, IF ext. papers ext. citations

#	Paper	IF	Citations
48	Review of radiation damage in GaN-based materials and devices. <i>Journal of Vacuum Science and Technology A: Vacuum, Surfaces and Films</i> , <b>2013</b> , 31, 050801	2.9	145
47	Radiation effects in GaN materials and devices. Journal of Materials Chemistry C, 2013, 1, 877-887	7.1	139
46	Isolation blocking voltage of nitrogen ion-implanted AlGaN/GaN high electron mobility transistor structure. <i>Applied Physics Letters</i> , <b>2010</b> , 97, 262116	3.4	43
45	Functionalization with MXene (Ti3C2) Enhances the Wettability and Shear Strength of Carbon Fiber-Epoxy Composites. <i>ACS Applied Nano Materials</i> , <b>2019</b> , 2, 5553-5562	5.6	35
44	Characterization of the gate oxide of an AlGaN/GaN high electron mobility transistor. <i>Applied Physics Letters</i> , <b>2011</b> , 98, 122103	3.4	30
43	Investigation of the effect of temperature during off-state degradation of AlGaN/GaN High Electron Mobility Transistors. <i>Microelectronics Reliability</i> , <b>2012</b> , 52, 23-28	1.2	29
42	Dependence on proton energy of degradation of AlGaN/GaN high electron mobility transistors. Journal of Vacuum Science and Technology B:Nanotechnology and Microelectronics, 2013, 31, 022201	1.3	29
41	Degradation Mechanisms for GaN and GaAs High Speed Transistors. <i>Materials</i> , <b>2012</b> , 5, 2498-2520	3.5	29
40	Comparison of neutron irradiation effects in AlGaN/AlN/GaN, AlGaN/GaN, and InAlN/GaN heterojunctions. <i>Journal of Vacuum Science and Technology B:Nanotechnology and Microelectronics</i> , <b>2012</b> , 30, 061207	1.3	28
39	Modeling Proton Irradiation in AlGaN/GaN HEMTs: Understanding the Increase of Critical Voltage. <i>IEEE Transactions on Nuclear Science</i> , <b>2013</b> , 60, 4103-4108	1.7	25
38	Three-Dimensional Porous Till -NiO Composite Electrodes with Enhanced Electrochemical Performance for Supercapacitors. <i>Materials</i> , <b>2019</b> , 12,	3.5	25
37	Effects of proton irradiation energies on degradation of AlGaN/GaN high electron mobility transistors. <i>Journal of Vacuum Science and Technology B:Nanotechnology and Microelectronics</i> , <b>2012</b> , 30, 012202	1.3	24
36	Effect of source field plate on the characteristics of off-state, step-stressed AlGaN/GaN high electron mobility transistors. <i>Journal of Vacuum Science and Technology B:Nanotechnology and Microelectronics</i> , <b>2011</b> , 29, 032204	1.3	23
35	Impact of proton irradiation on dc performance of AlGaN/GaN high electron mobility transistors. <i>Journal of Vacuum Science and Technology B:Nanotechnology and Microelectronics</i> , <b>2013</b> , 31, 042202	1.3	20
34	Effect of electron irradiation on AlGaN/GaN and InAlN/GaN heterojunctions. <i>Journal of Vacuum Science and Technology B:Nanotechnology and Microelectronics</i> , <b>2013</b> , 31, 022206	1.3	19
33	Improvement of Off-State Stress Critical Voltage by Using Pt-Gated AlGaN/GaN High Electron Mobility Transistors. <i>Electrochemical and Solid-State Letters</i> , <b>2011</b> , 14, H264		19
32	Inkjet Printing Transparent and Conductive MXene (TiC) Films: A Strategy for Flexible Energy Storage Devices. <i>ACS Applied Materials &amp; Storage Devices</i> . 13, 17766-17780	9.5	19

31	Effects of proton irradiation on dc characteristics of InAlN/GaN high electron mobility transistors.  Journal of Vacuum Science and Technology B:Nanotechnology and Microelectronics, 2011, 29, 061201	3	17
30	Effect of temperature on CO sensing response in air ambient by using ZnO nanorod-gated AlGaN/GaN high electron mobility transistors. <i>Sensors and Actuators B: Chemical</i> , <b>2013</b> , 176, 708-712	3.5	16
29	Effect of buffer structures on AlGaN/GaN high electron mobility transistor reliability. <i>Journal of Vacuum Science and Technology B:Nanotechnology and Microelectronics</i> , <b>2013</b> , 31, 011805	<b>-</b> .3	16
28	Annealing temperature dependence of Ohmic contact resistance and morphology on InAlN/GaN high electron mobility transistor structures. <i>Journal of Vacuum Science and Technology</i> 18:Nanotechnology and Microelectronics, <b>2011</b> , 29, 021002	3	14
27	Effect of buffer layer structure on electrical and structural properties of AlGaN/GaN high electron mobility transistors. <i>Journal of Vacuum Science and Technology B:Nanotechnology and Microelectronics</i> , <b>2012</b> , 30, 011205	2.3	13
26	Study on the effects of proton irradiation on the dc characteristics of AlGaN/GaN high electron mobility transistors with source field plate. <i>Journal of Vacuum Science and Technology</i> 18:Nanotechnology and Microelectronics, <b>2014</b> , 32, 022202	<b>-</b> .3	12
25	Transmission electron microscopy characterization of electrically stressed AlGaN/GaN high electron mobility transistor devices. <i>Journal of Vacuum Science and Technology B:Nanotechnology and Microelectronics</i> , <b>2012</b> , 30, 062204	<b>-</b> .3	12
24	Under-gate defect formation in Ni-gate AlGaN/GaN high electron mobility transistors.  Microelectronics Reliability, <b>2012</b> , 52, 2542-2546	.2	11
23	Comparison of passivation layers for AlGaN/GaN high electron mobility transistors. <i>Journal of Vacuum Science and Technology B:Nanotechnology and Microelectronics</i> , <b>2011</b> , 29, 061204	3	11
22	Investigating the effect of off-state stress on trap densities in AlGaN/GaN high electron mobility transistors. <i>Journal of Vacuum Science and Technology B:Nanotechnology and Microelectronics</i> , <b>2011</b> , 129, 060603	3	11
21	Electrical characterization of 60Co gamma radiation-exposed InAlN/GaN high electron mobility transistors. <i>Journal of Vacuum Science and Technology B:Nanotechnology and Microelectronics</i> , <b>2013</b> , 31, 051210	3	10
20	Proton irradiation energy dependence of dc and rf characteristics on InAlN/GaN high electron mobility transistors. <i>Journal of Vacuum Science and Technology B:Nanotechnology and Microelectronics</i> , <b>2012</b> , 30, 041206	<u>3</u>	9
19	Effects of 2 MeV Ge+ irradiation on AlGaN/GaN high electron mobility transistors. <i>Journal of Vacuum Science and Technology B:Nanotechnology and Microelectronics</i> , <b>2013</b> , 31, 021205	<b>.</b> .3	8
18	Circular and rectangular via holes formed in SiC via using ArF based UV excimer laser. <i>Applied Surface Science</i> , <b>2011</b> , 257, 2303-2307	б.7	8
17	Effects of silicon nitride passivation on isolation-blocking voltage in algan/gan high electron mobility transistors. <i>Journal of Vacuum Science and Technology B:Nanotechnology and Microelectronics</i> , <b>2011</b> , 29, 031211	3	8
16	Carbon monoxide detection sensitivity of ZnO nanorod-gated AlGaN/GaN high electron mobility transistors in different temperature environments. <i>Journal of Vacuum Science and Technology</i> 18:Nanotechnology and Microelectronics, <b>2012</b> , 30, 010606	-3	7
15	Construction of biomimetic artificial intervertebral disc scaffold via 3D printing and electrospinning. <i>Materials Science and Engineering C</i> , <b>2021</b> , 128, 112310	3.3	7
14	Methane detection using Pt-gated AlGaN/GaN high electron mobility transistor based Schottky diodes. <i>Journal of Vacuum Science and Technology B:Nanotechnology and Microelectronics</i> , <b>2013</b> , 31, 03220	03	6

13	Thermal simulation of laser lift-off AlGaN/GaN high electron mobility transistors mounted on AlN substrates. <i>Journal of Vacuum Science and Technology B:Nanotechnology and Microelectronics</i> , <b>2011</b> , 29, 041202	1.3	6	
12	Degradation of dc characteristics of InAlN/GaN high electron mobility transistors by 5 MeV proton irradiation. <i>Journal of Vacuum Science and Technology B:Nanotechnology and Microelectronics</i> , <b>2012</b> , 30, 031202	1.3	5	
11	MXene (TiCT) Functionalized Short Carbon Fibers as a Cross-Scale Mechanical Reinforcement for Epoxy Composites. <i>Polymers</i> , <b>2021</b> , 13,	4.5	5	
10	PVdF-HFP-Based Gel Polymer Electrolyte with Semi-Interpenetrating Networks For Dendrite-Free Lithium Metal Battery. <i>Acta Metallurgica Sinica (English Letters)</i> , <b>2021</b> , 34, 417-424	2.5	5	
9	Effect of Drain Bias on Degradation of AlGaN©aN High Electron Mobility Transistors under X-Band Operation. <i>Electrochemical and Solid-State Letters</i> , <b>2011</b> , 14, H464		4	
8	Radiation Damage in GaN-Based Materials and Devices <b>2014</b> , 345-387		3	
7	193 nm excimer laser lift-off for AlGaN/GaN high electron mobility transistors. <i>Journal of Vacuum Science and Technology B:Nanotechnology and Microelectronics</i> , <b>2012</b> , 30, 051209	1.3	3	
6	Comparison of DC performance of Pt/Ti/Au- and Ni/Au-gated AlGaN/GaN high electron mobility transistors. <i>Journal of Vacuum Science and Technology B:Nanotechnology and Microelectronics</i> , <b>2011</b> , 29, 042202	1.3	3	
5	Attapulgite-MXene Hybrids with TiCT Lamellae Surface Modified by Attapulgite as a Mechanical Reinforcement for Epoxy Composites. <i>Polymers</i> , <b>2021</b> , 13,	4.5	3	
4	Radiation Damage in GaN-Based Materials and Devices <b>2013</b> , 1753-1764		1	
3	Radiation Damage in GaN-Based Materials and Devices <b>2013</b> , 1753-1764		1	
2	Mechanical properties of phase-pure bulk Ta4AlC3 prepared by spark plasma sintering and subsequent heat treatment. <i>Processing and Application of Ceramics</i> , <b>2021</b> , 15, 211-218	1.4	O	
1	Flexible and High-Performance MXene/MnO2 Film Electrodes Fabricated by Inkjet Printing: Toward a New Generation Supercapacitive Application (Adv. Mater. Interfaces 21/2021). <i>Advanced Materials Interfaces</i> , <b>2021</b> , 8, 2170117	4.6		